

## VCC 0 1.6 k 1.6 k 0

This device consists of three independent 3-input AND gates. The outputs of each gate are available as ORing nodes. Using the MC3019 expander, with the MC3031 expandable gate, up to six AND gates can be ORed together.

MC3100/MC3000 series



Input Loading Factor = 1 Full output loading factor of the expandable gate is maintained.

Total Power Dissipation = 25 mW typ/pkg Propagation Delay Time:  $\Delta t_{pd1} = +0.4 \text{ ns typ}$   $\Delta t_{pd0} = +0.05 \text{ ns typ}$ When added to the expandable "AND-OR" gate.

 $\begin{array}{l} \Delta t_{pd1}/p\text{F}=+0.3 \text{ ns/pF typ} \\ \Delta t_{pd0}/p\text{F}=+0.04 \text{ ns/pF typ} \\ \text{Caused by additional capacitance} \\ \text{at expansion points.} \end{array}$ 

Pin numbers for the 54H61F/74H61F device are shown in the chart. These devices are available on special request.

device are	DEVICE						PIN	NU	MBE	RS					
vailable on	MC3119F,L/3019F,L,P	1	2	3	4	5	6	7	8	9	10	11	12	13	14
	54H61F/74H61F	1	2	3	5	6	7	11	13	14	12	8	9	10	4





ELECTRICAL CHARACTERISTICS

Test procedures are shown for only one expander. The other expander is tested in a similar manner. Further, test procedures are shown for only one input of the ex-pander being tested. To complete testing, sequence through remaining inputs.

525 11 5 9

TEST CURRENT/VOLTAGE VALUES

Volts

Ł

			12	П	1º								•			M					-	VOITS						
			13 [	]									Tem	@ lest Temperature	10	<u>s</u>	_0	× ×	V <sub>RH</sub>	Υ <sub>F</sub>	V <sub>CEX</sub>	۲ ۳	ν"	V <sub>IH</sub> V <sub>IL</sub> V <sub>max</sub> V <sub>CC</sub> V <sub>CC1</sub> V <sub>CCH</sub>	, s	CCI /	HO	
													)	-55°C	4.5		ŀ	2.4	4.0	0.4	2.2	2.0	0.8		5.0	4.5	5.5	
												MC3119	~	+25°C	5.5	1.0	-10	2.4	4.0	0.4	2.2	1.8	0.8	7.0	5.0	4.5	5.5	
													-	+125°C	7.3			2.4	4.0	0.4	2.2	1.8	0.8		5.0	4.5	5.5	
													)	0°C	5.35	i	ŀ	2.5	4.0	0.4	2.2	2.0	0.8	1	5.0 4	4.75 5	5.25	
												MC3019	610	+25°C	5.5	1.0	-10	2.5	4.0	0.4	2.2	1.8	0.8	7.0	5.0 4	4.75 5.	5.25	
													-	+75°C	6.2			2.5	4.0	0.4	2.2	1.8	0.8		5.0 4	4.75 5	5.25	
		pin		MC	MC3119 T	<b>Test Limits</b>	its			WC	3019	MC3019 Test Limits	iits				H	ST CUR	TEST CURRENT/VOLTAGE APPLIED TO PINS LISTED BELOW:	GF APP	IED TO	SNId	ISTED	BELOW				
	<u></u>	Under		-55°C	+25°C	2°C	+125°C	2°C	0°C		+25°C	-	+75°C			L	:									F	Т	
Characteristics	Symbol		L	Min Max	Min	Max	Min	Max /	Min M	Max M	Min Max	ax Min	Max Nax	Lin I	_d	s	-	>*	V <sub>RH</sub>	۲, ۲	Vcex	H >	V <sub>IL</sub> V <sub>max</sub>		200	Vcci.	VccH	Gnd
Input			-				1		-	-	-		_															
Forward Current	IF	1	1	-2.0	1.	-2.0	,	-2.0	-2-	-2.0 -	-2.0	- 0	-2.0	mAdc	1	•	•	1	2,3	1	•	•			,	,	14	*2
Leakage Current	I <sub>R</sub>	-		50	1.	50		50		50 -	50	-	50	μAdc				1						1.	,	-	14	2,3,7
Breakdown Voltage	BVin	-	1	1	5.5	,	1	,		- 22	- 2	-		Vdc										1			14	2,3,7
Clamp Voltage	V <sub>D</sub>	1	-	1	•	-1.5			.,		-1-	، ي	,	Vdc	•	,	-	1		•	,					14	-	**
Output									-	-	-															-		
Output Voltage	VOL	6		1.0		1.0	1	1.0	-	1.0 -	1.0		1.0	Vdc	6	,	1		•	,	,	1,2,3	,	,	,	14	-	7*
Emitter Current	ICEX	6	1	50		50	1	50		- 09	50		50	μAdc	1	1	•		2,3	1	6	1	1	,		14	-	7
Power Requirements (Total Device) Maximum Power Supply Current	Imax	14	-	I.	з <b>.</b> 1	9.0		,		'	9.0	. ,		mAdc	1	ì		1	1	1			,	14		1	- 1,	1,2,3,4,5, 6,7,11,12,13
	HŪďI	14	1	18	,	18		18	-	- 18	18	•	18	mAdc		•	•	1	1,2,3,4,5,6,11,12,13	r'			,	1		-	14	7
Power Supply Drain	IPDL	14	· 1	6.75	1	6.75	9	6.75		6.75 -	6.75		6.75	mAdc	'	11	•			1	•	ı	,	1	1	-	14 1,	1,2,3,4,5, 6,7,11,12,13
*Ground inputs to gates not under test.	not under	test.																			1	1						